

## AOD606

### Complementary Enhancement Mode Field Effect Transistor

#### General Description

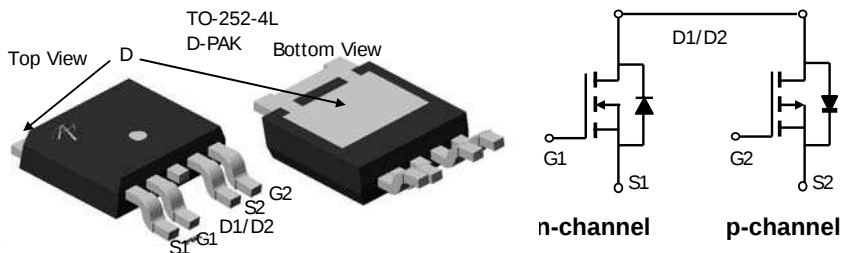
The AOD606 uses advanced trench technology MOSFETs to provide excellent  $R_{DS(ON)}$  and low gate charge. The complementary MOSFETs may be used in H-bridge, Inverters and other applications.

-RoHS Compliant  
-Halogen Free\*

#### Features

|                              |                                 |
|------------------------------|---------------------------------|
| n-channel                    | p-channel                       |
| $V_{DS} (V) = 40V$           | -40V                            |
| $I_D = 8A (V_{GS}=10V)$      | -8A ( $V_{GS} = -10V$ )         |
| $R_{DS(ON)}$                 | $R_{DS(ON)}$                    |
| $< 33 m\Omega (V_{GS}=10V)$  | $< 50 m\Omega (V_{GS} = -10V)$  |
| $< 47 m\Omega (V_{GS}=4.5V)$ | $< 70 m\Omega (V_{GS} = -4.5V)$ |

**100% UIS Tested!**



#### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                                          | Symbol         | Max n-channel | Max p-channel | Units      |
|----------------------------------------------------|----------------|---------------|---------------|------------|
| Drain-Source Voltage                               | $V_{DS}$       | 40            | -40           | V          |
| Gate-Source Voltage                                | $V_{GS}$       | $\pm 20$      | $\pm 20$      | V          |
| Continuous Drain Current <sup>G</sup>              | $I_D$          | 8             | -8            | A          |
| $T_C=25^\circ C$                                   |                | 6.3           | -6.3          |            |
| $T_C=100^\circ C$                                  | $I_D$          | 6.3           | -6.3          | A          |
| Pulsed Drain Current <sup>C</sup>                  | $I_{DM}$       | 30            | -30           | A          |
| Avalanche Current <sup>C</sup>                     | $I_{AR}$       | 12            | 14            | A          |
| Repetitive avalanche energy $L=0.3mH$ <sup>C</sup> | $E_{AR}$       | 21.6          | 29.4          | mJ         |
| Power Dissipation <sup>B</sup>                     | $P_D$          | 20            | 30            | W          |
| $T_C=25^\circ C$                                   |                | 10            | 15            |            |
| $T_C=100^\circ C$                                  | $P_D$          | 10            | 15            | W          |
| Power Dissipation <sup>A</sup>                     | $P_{DSM}$      | 1.6           | 1.7           | W          |
| $T_A=25^\circ C$                                   |                | 1             | 1.1           |            |
| $T_A=70^\circ C$                                   | $P_{DSM}$      | 1             | 1.1           | W          |
| Junction and Storage Temperature Range             | $T_J, T_{STG}$ | -55 to 175    | -55 to 175    | $^\circ C$ |

#### Thermal Characteristics: n-channel and p-channel

| Parameter                                | Symbol          | Device | Typ | Max | Units        |
|------------------------------------------|-----------------|--------|-----|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | n-ch   | 25  | 30  | $^\circ C/W$ |
| $t \leq 10s$                             |                 | n-ch   | 66  | 80  | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | p-ch   | 17  | 25  | $^\circ C/W$ |
| Steady-State                             |                 | p-ch   | 60  | 75  | $^\circ C/W$ |
| Maximum Junction-to-Case <sup>B</sup>    | $R_{\theta JC}$ | n-ch   | 7   | 7.5 | $^\circ C/W$ |
| Steady-State                             | $R_{\theta JC}$ | p-ch   | 4   | 5   | $^\circ C/W$ |

N-Channel MOSFET Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                              | Conditions                                                                                | Min | Typ  | Max    | Units |
|-----------------------------|----------------------------------------|-------------------------------------------------------------------------------------------|-----|------|--------|-------|
| <b>STATIC PARAMETERS</b>    |                                        |                                                                                           |     |      |        |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage         | I <sub>D</sub> =10mA, V <sub>GS</sub> =0V                                                 | 40  |      |        | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current        | V <sub>DS</sub> =32V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |      | 1<br>5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current              | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V                                                |     |      | 100    | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                 | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                  | 1.5 | 2.3  | 3      | V     |
| I <sub>D(ON)</sub>          | On state drain current                 | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V                                                 | 30  |      |        | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance      | V <sub>GS</sub> =10V, I <sub>D</sub> =8A                                                  |     | 27   | 33     | mΩ    |
|                             |                                        | T <sub>J</sub> =125°C                                                                     |     | 39   | 52     |       |
|                             |                                        | V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A                                                 |     | 37   | 47     | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance               | V <sub>DS</sub> =5V, I <sub>D</sub> =8A                                                   |     | 25   |        | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                  | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                   |     | 0.76 | 1      | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current  |                                                                                           |     |      | 8      | A     |
| I <sub>SM</sub>             | Pulsed Body-Diode Current <sup>C</sup> |                                                                                           |     |      | 30     | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                        |                                                                                           |     |      |        |       |
| C <sub>ISS</sub>            | Input Capacitance                      | V <sub>GS</sub> =0V, V <sub>DS</sub> =20V, f=1MHz                                         |     | 404  |        | pF    |
| C <sub>OSS</sub>            | Output Capacitance                     |                                                                                           |     | 95   |        | pF    |
| C <sub>RSS</sub>            | Reverse Transfer Capacitance           |                                                                                           |     | 37   |        | pF    |
| R <sub>g</sub>              | Gate resistance                        | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                          |     | 2.7  |        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                        |                                                                                           |     |      |        |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                      | V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, I <sub>D</sub> =8A                            |     | 9.2  |        | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                      |                                                                                           |     | 4.5  |        | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                     |                                                                                           |     | 1.6  |        | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                      |                                                                                           |     | 2.6  |        | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                      | V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, R <sub>L</sub> =2.5Ω,<br>R <sub>GEN</sub> =3Ω |     | 3.5  |        | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                      |                                                                                           |     | 6    |        | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                     |                                                                                           |     | 13.2 |        | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                     |                                                                                           |     | 3.5  |        | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time       | I <sub>F</sub> =8A, dI/dt=100A/μs                                                         |     | 22.9 |        | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge     | I <sub>F</sub> =8A, dI/dt=100A/μs                                                         |     | 18.3 |        | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B: The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=175°C.

D: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=175°C.

G: The maximum current rating is limited by bond-wires.

H: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

\*This device is guaranteed green after data code 8X11 (Sep 1<sup>ST</sup> 2008).

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## N-Channel MOSFET TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

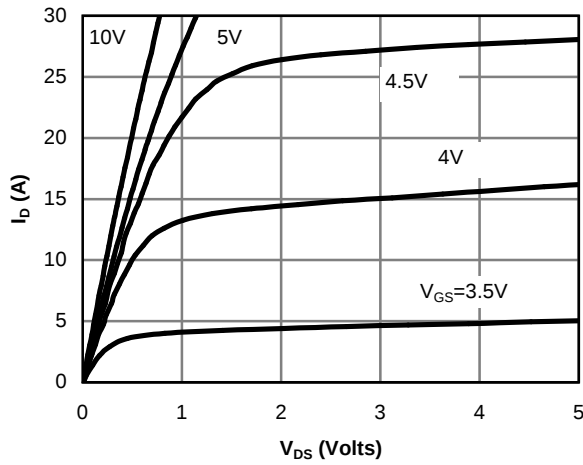


Fig 1: On-Region Characteristics

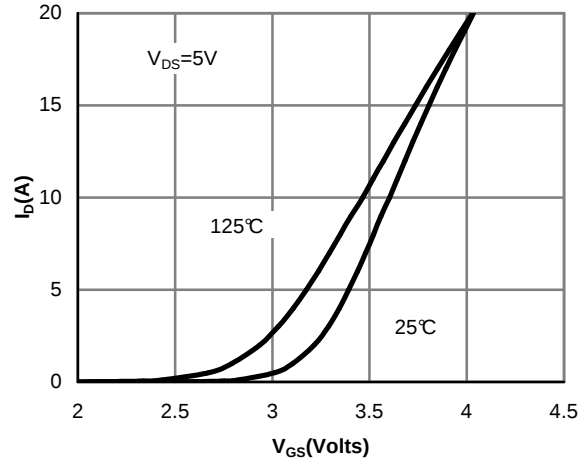


Figure 2: Transfer Characteristics

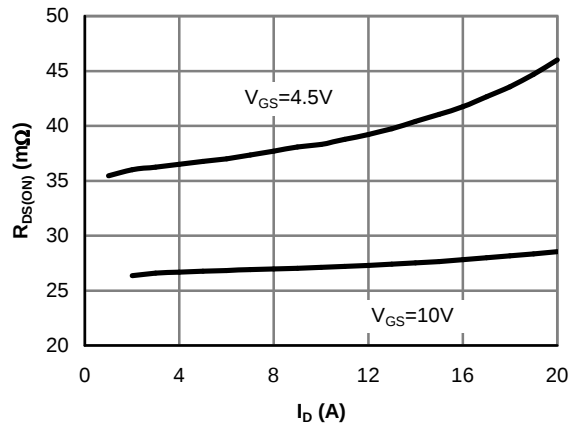


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

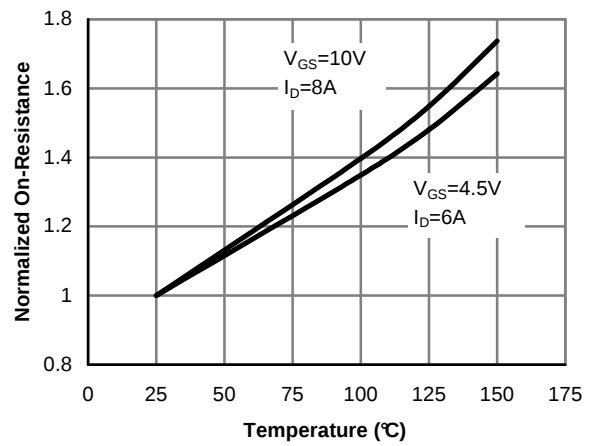


Figure 4: On-Resistance vs. Junction Temperature

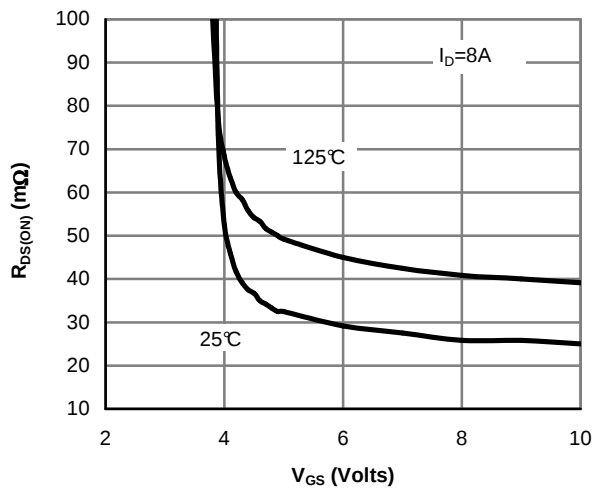


Figure 5: On-Resistance vs. Gate-Source Voltage

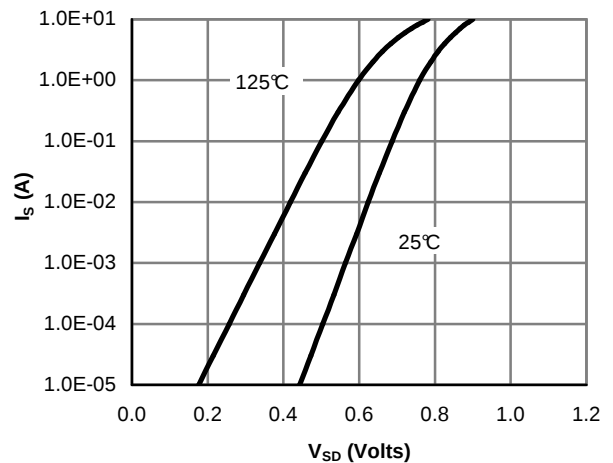


Figure 6: Body-Diode Characteristics

## N-Channel MOSFET TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

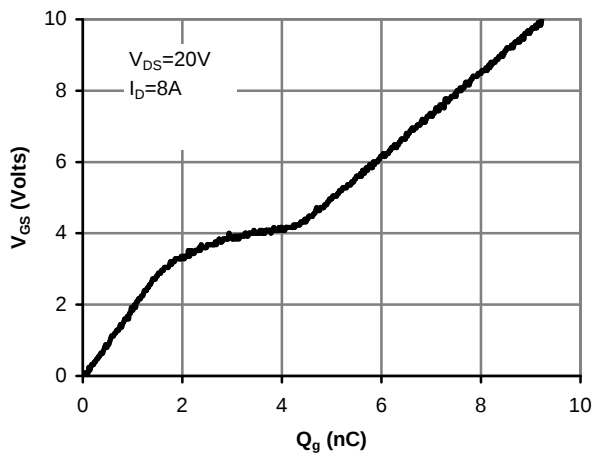


Figure 7: Gate-Charge Characteristics

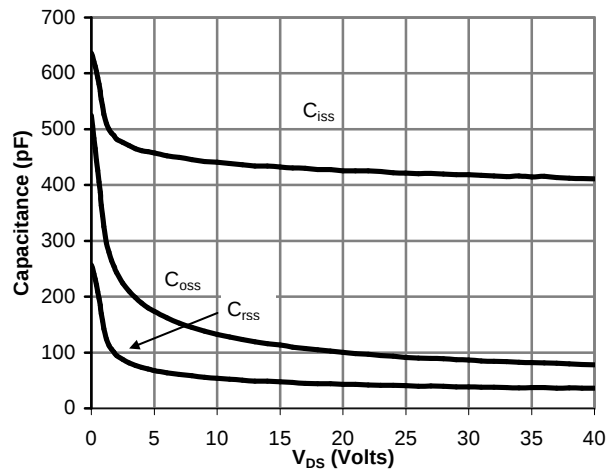


Figure 8: Capacitance Characteristics

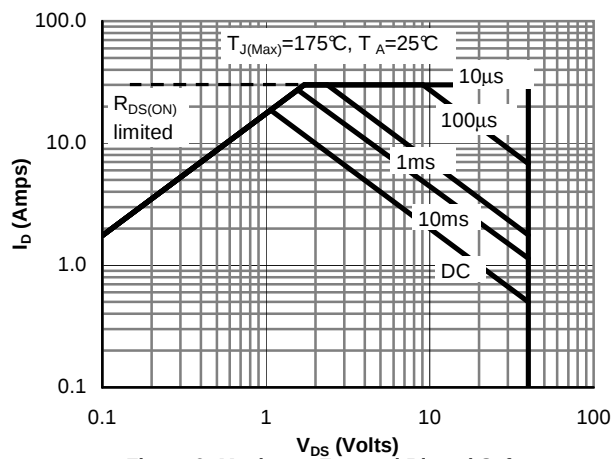


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

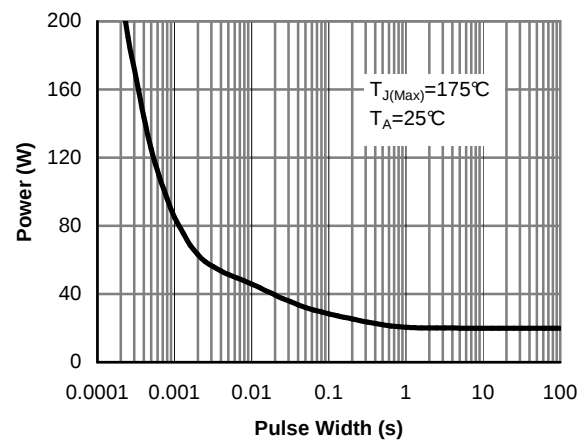


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

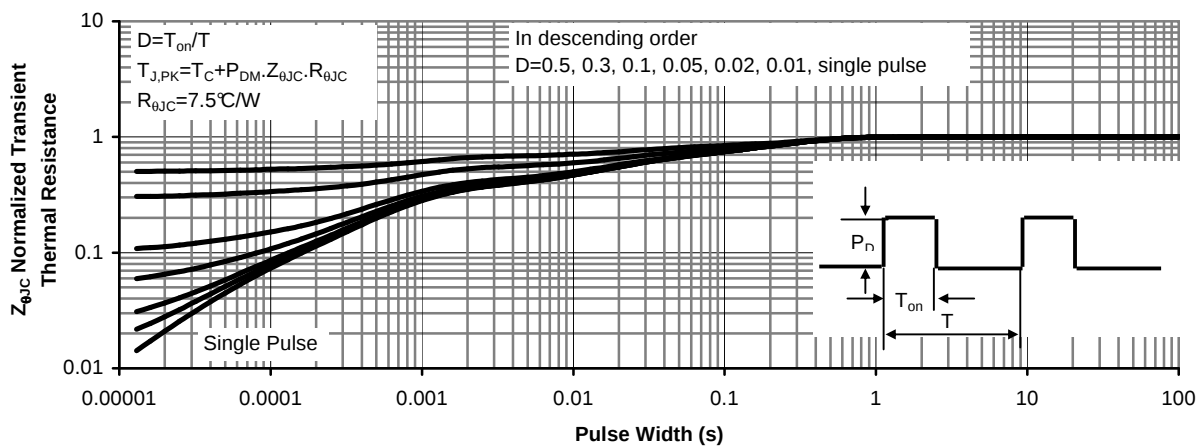
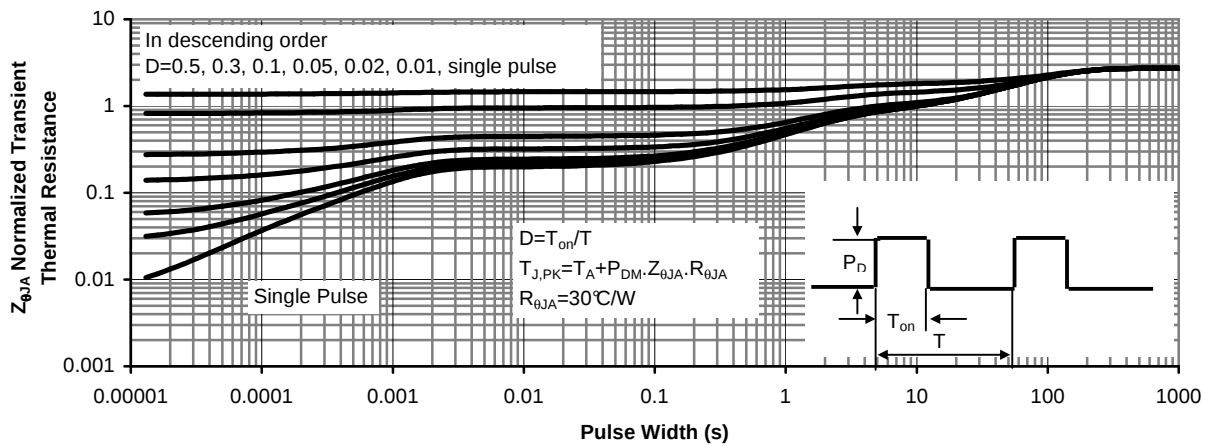
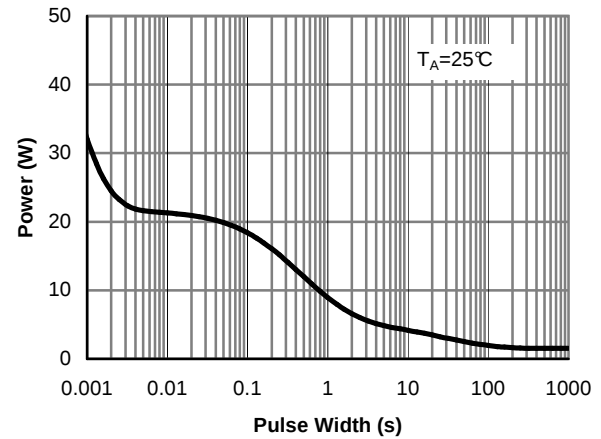
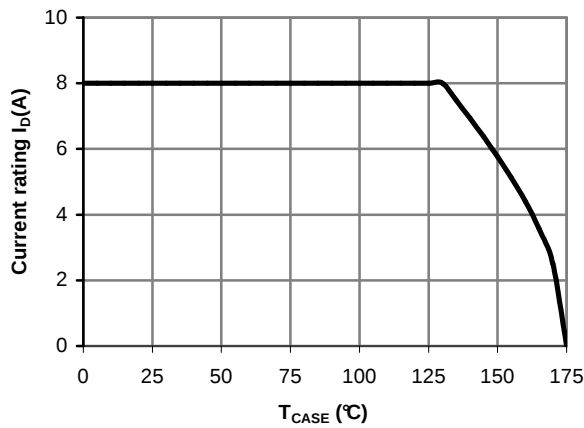
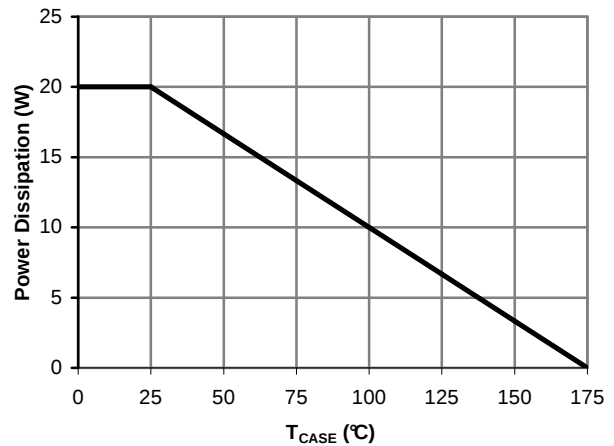
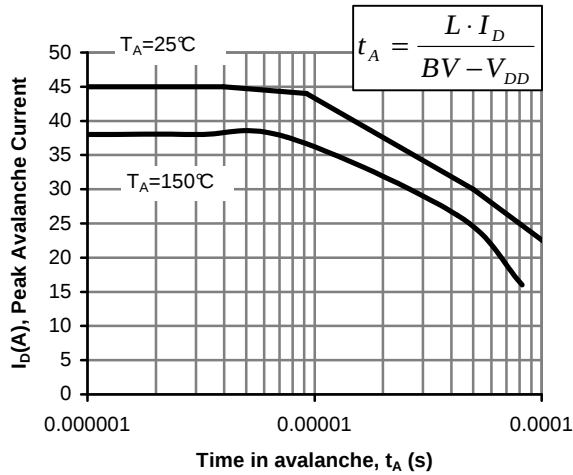


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

## N-Channel MOSFET TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



P-Channel MOSFET Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                              | Conditions                                                                                  | Min  | Typ      | Max      | Units |
|-----------------------------|----------------------------------------|---------------------------------------------------------------------------------------------|------|----------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                        |                                                                                             |      |          |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage         | I <sub>D</sub> =-10mA, V <sub>GS</sub> =0V                                                  | -40  |          |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current        | V <sub>DS</sub> =-32V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |      |          | -1<br>-5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current              | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V                                                  |      |          | ±100     | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                 | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                                   | -1.5 | -1.8     | -3       | V     |
| I <sub>D(ON)</sub>          | On state drain current                 | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V                                                 | -30  |          |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance      | V <sub>GS</sub> =-10V, I <sub>D</sub> =-8A<br>T <sub>J</sub> =125°C                         |      | 35<br>62 | 50       | mΩ    |
|                             |                                        | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-4A                                                 |      | 55       | 70       | mΩ    |
|                             |                                        |                                                                                             |      |          |          |       |
| g <sub>FS</sub>             | Forward Transconductance               | V <sub>DS</sub> =-5V, I <sub>D</sub> =-8A                                                   |      | 16       |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                  | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V                                                    |      | -0.75    | -1       | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current  |                                                                                             |      |          | -8       | A     |
| I <sub>SM</sub>             | Pulsed Body-Diode Current <sup>C</sup> |                                                                                             |      |          | -30      | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                        |                                                                                             |      |          |          |       |
| C <sub>ISS</sub>            | Input Capacitance                      | V <sub>GS</sub> =0V, V <sub>DS</sub> =-20V, f=1MHz                                          |      | 657      |          | pF    |
| C <sub>OSS</sub>            | Output Capacitance                     |                                                                                             |      | 143      |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance           |                                                                                             |      | 63       |          | pF    |
| R <sub>g</sub>              | Gate resistance                        | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                            |      | 6.5      |          | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                        |                                                                                             |      |          |          |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge (10V)                | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-20V, I <sub>D</sub> =-8A                           |      | 14.1     |          | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge (4.5V)               |                                                                                             |      | 7        |          | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                     |                                                                                             |      | 2.2      |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                      |                                                                                             |      | 4.1      |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                      | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-20V, R <sub>L</sub> =2.5Ω,<br>R <sub>GEN</sub> =3Ω |      | 8        |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                      |                                                                                             |      | 12.2     |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                     |                                                                                             |      | 24       |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                     |                                                                                             |      | 12.5     |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time       | I <sub>F</sub> =-8A, dI/dt=100A/μs                                                          |      | 23.2     |          | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge     | I <sub>F</sub> =-8A, dI/dt=100A/μs                                                          |      | 18.2     |          | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B: The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=175°C.

D: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=175°C.

G: The maximum current rating is limited by bond-wires.

H: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

\*This device is guaranteed green after data code 8X11 (Sep 1<sup>ST</sup> 2008).

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# P-Channel MOSFET Electrical Characteristics ( $T_J=25^\circ\text{C}$ unless otherwise noted)

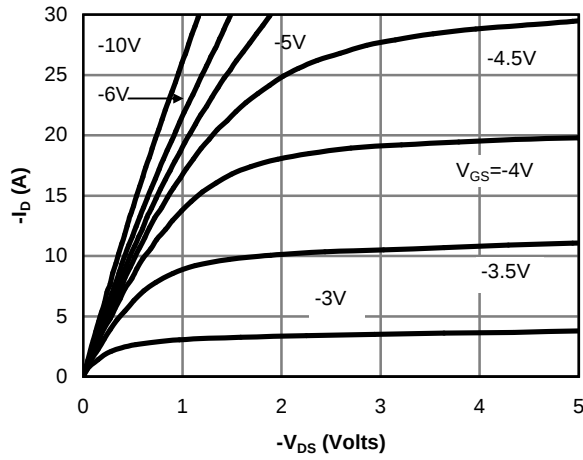


Fig 1: On-Region Characteristics

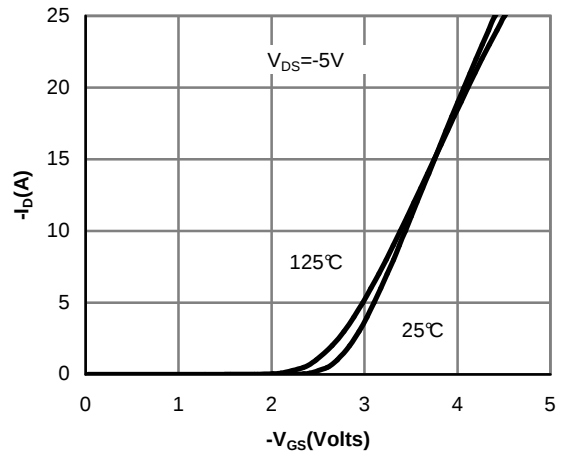


Figure 2: Transfer Characteristics

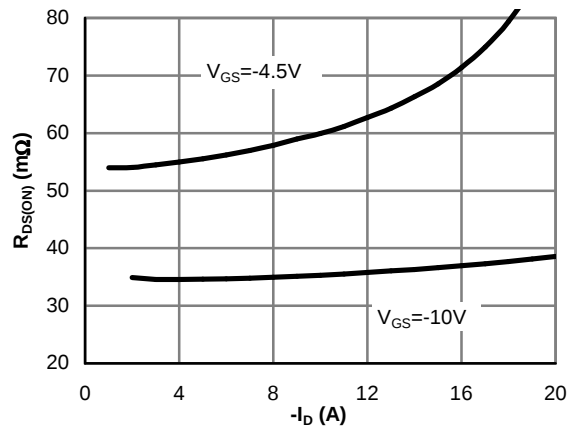


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

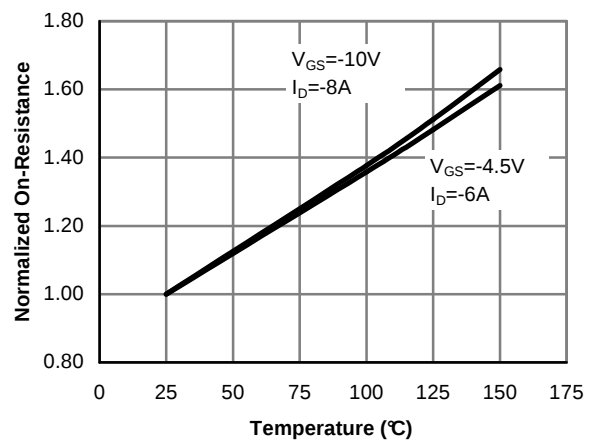


Figure 4: On-Resistance vs. Junction Temperature

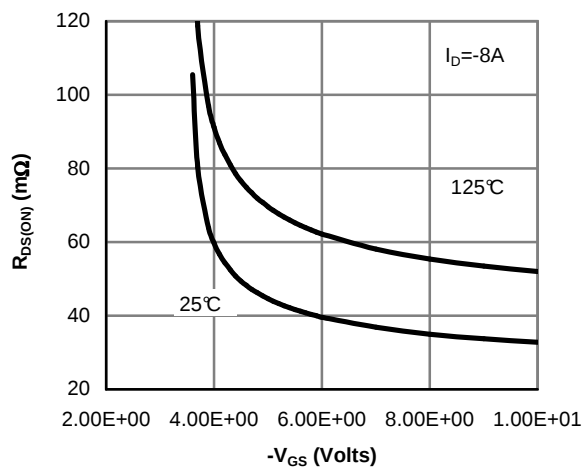


Figure 5: On-Resistance vs. Gate-Source Voltage

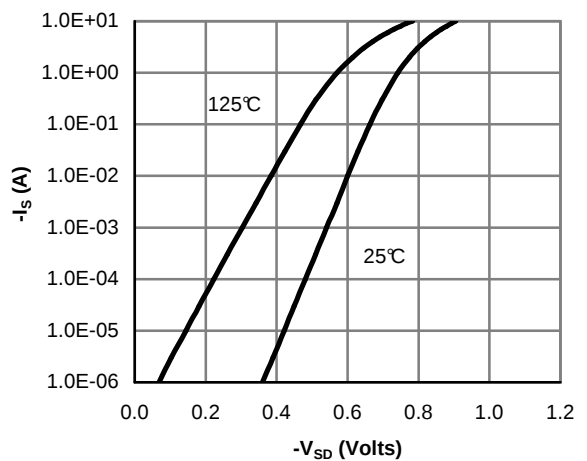


Figure 6: Body-Diode Characteristics

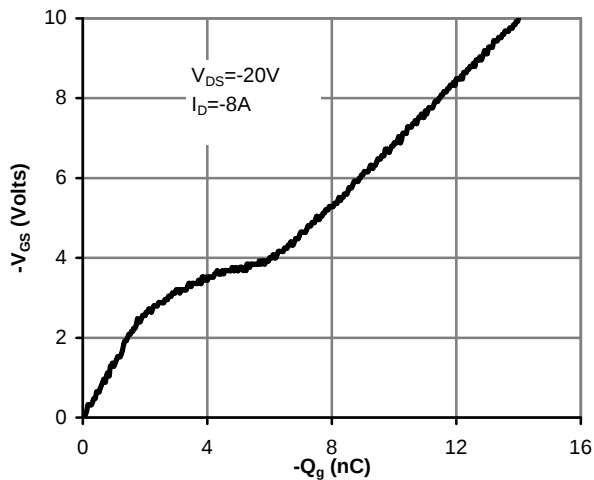
P-Channel MOSFET Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

Figure 7: Gate-Charge Characteristics

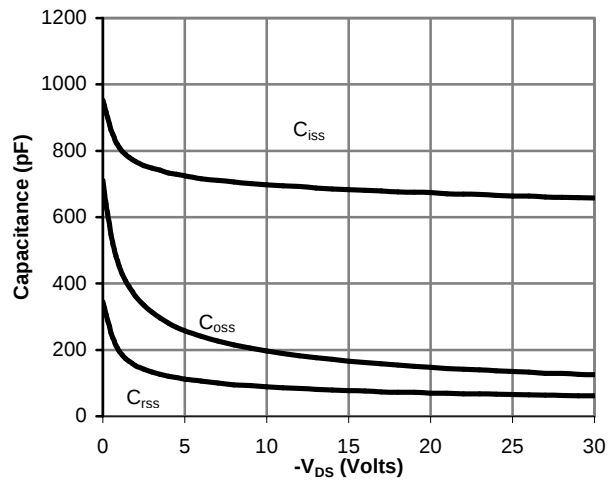


Figure 8: Capacitance Characteristics

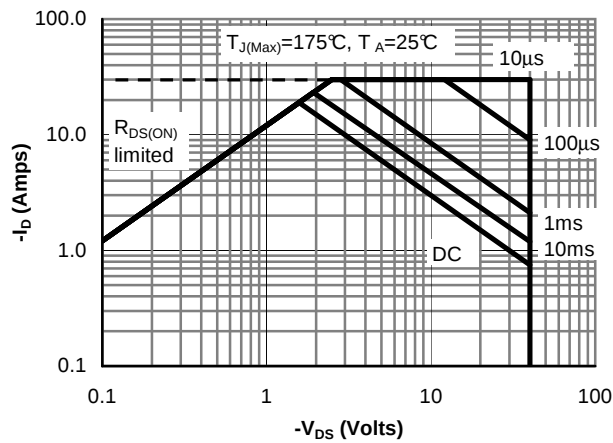


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

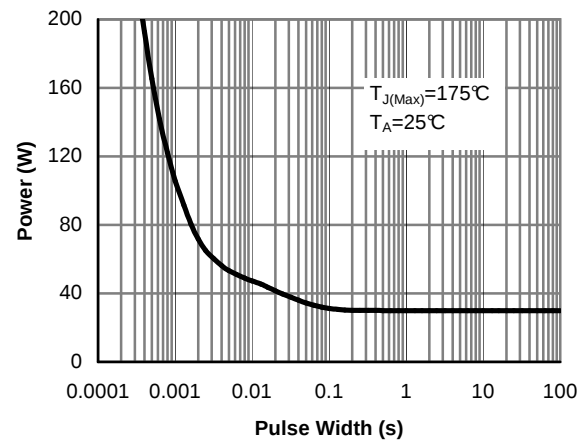


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

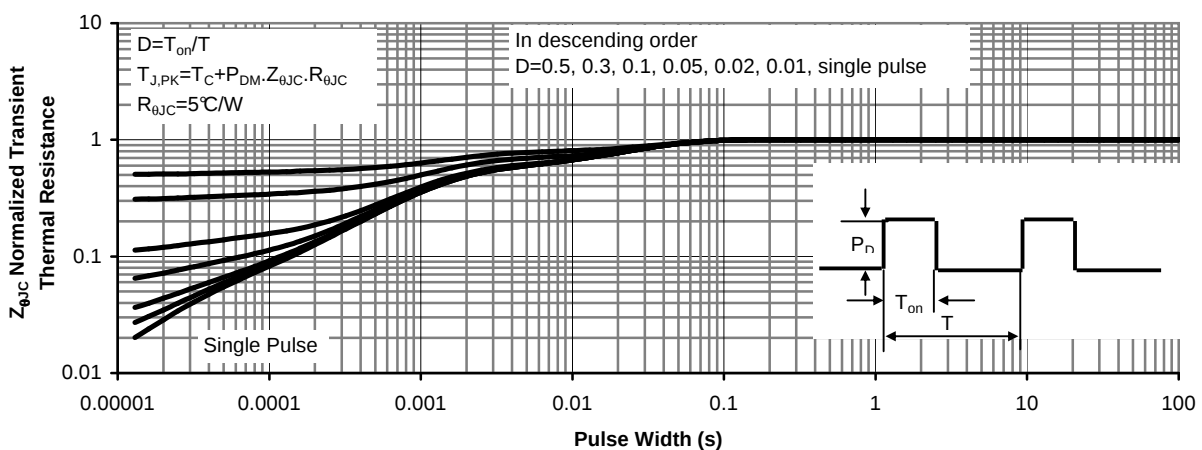


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

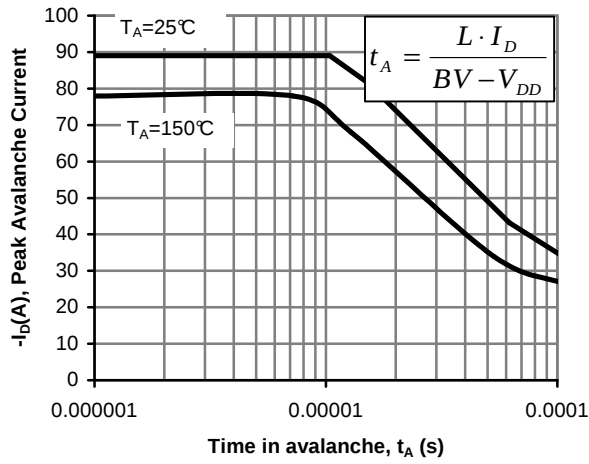
P-Channel MOSFET Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

Figure 12: Single Pulse Avalanche capability

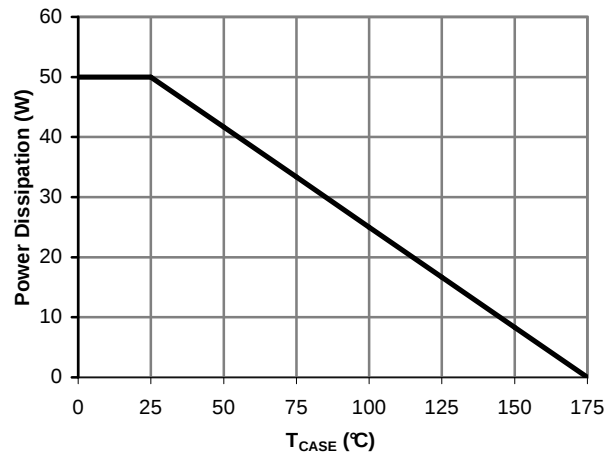


Figure 13: Power De-rating (Note B)

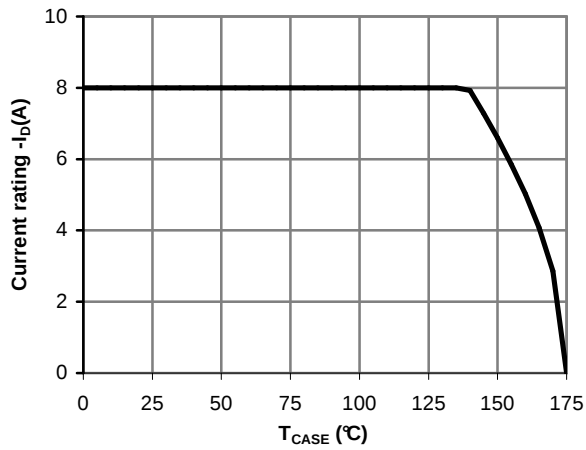


Figure 14: Current De-rating (Note B)

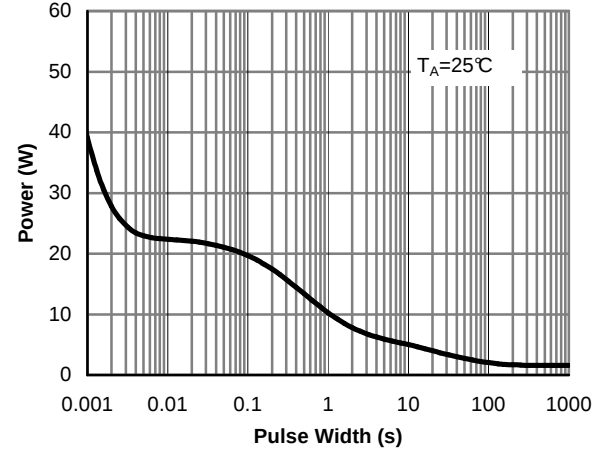


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

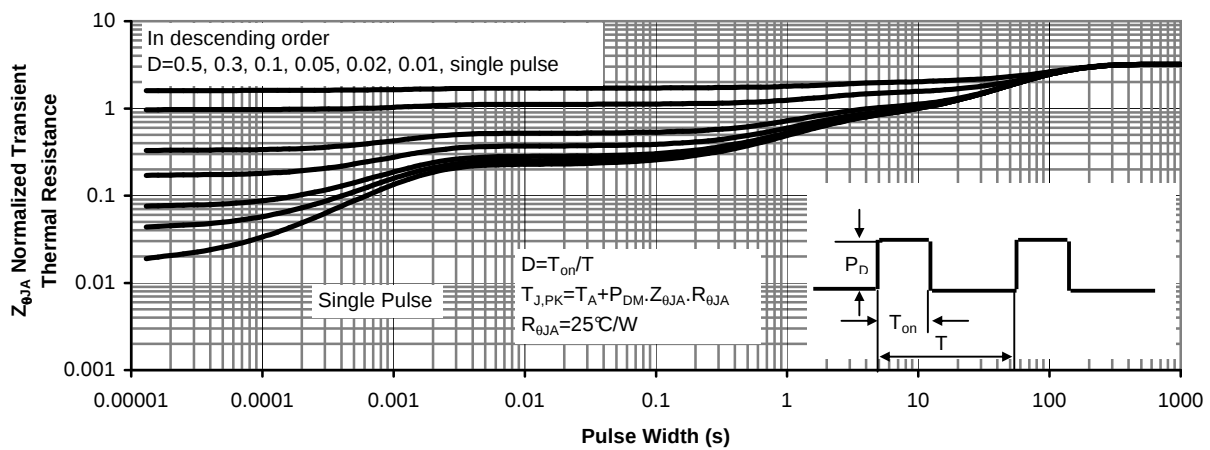
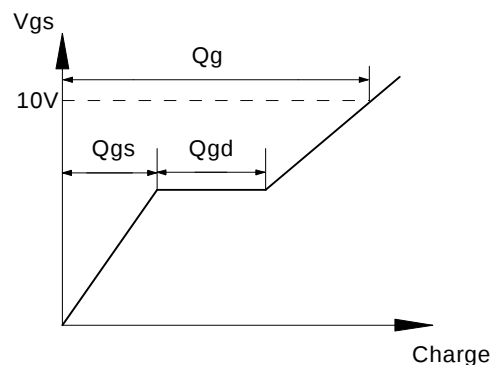
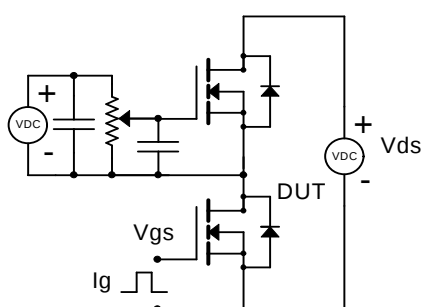
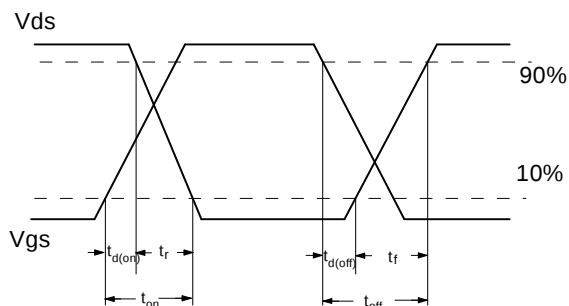
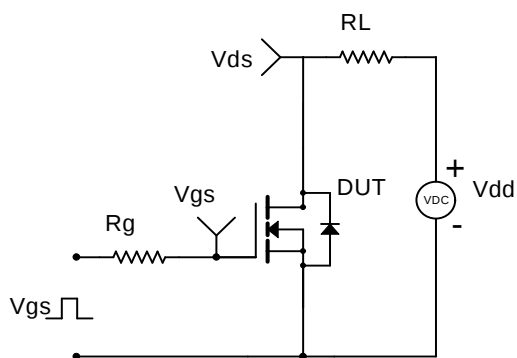


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

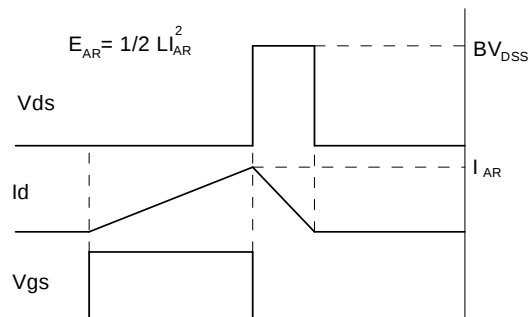
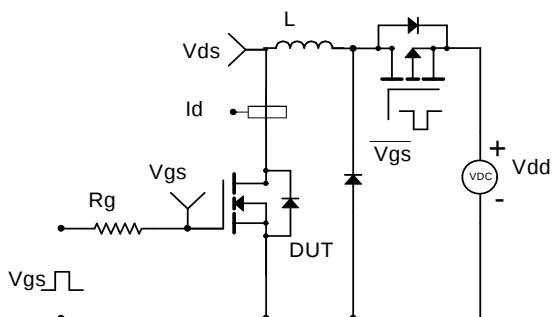
## Gate Charge Test Circuit &amp; Waveform



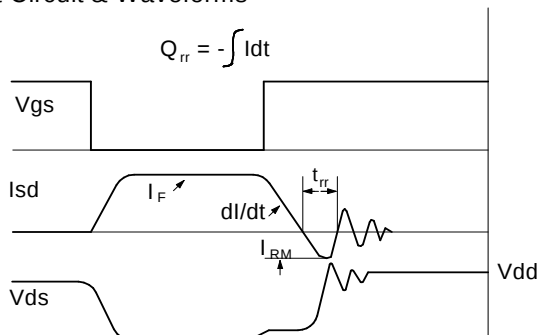
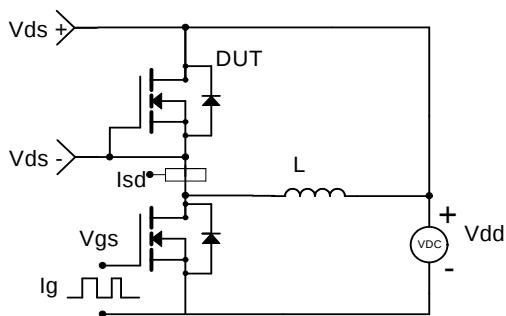
## Resistive Switching Test Circuit &amp; Waveforms



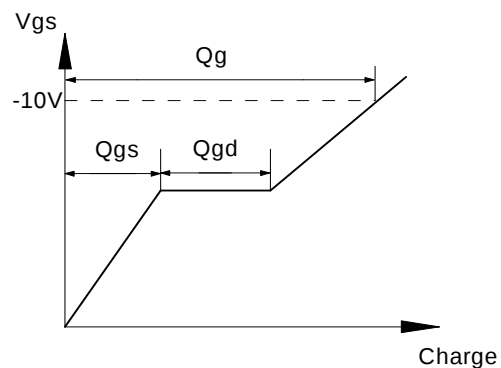
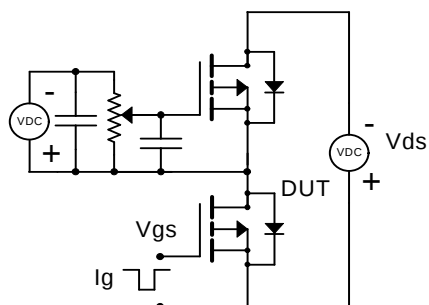
## Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



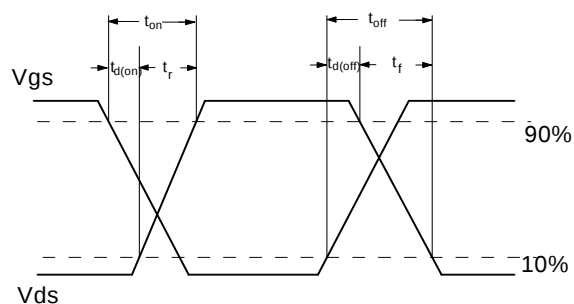
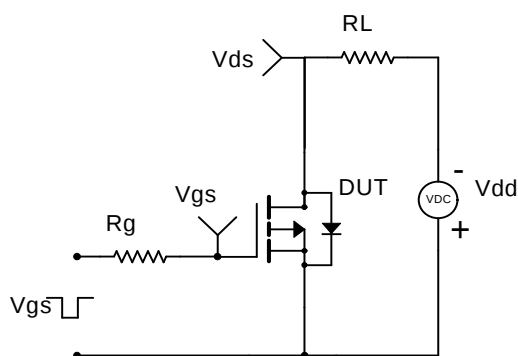
## Diode Recovery Test Circuit &amp; Waveforms



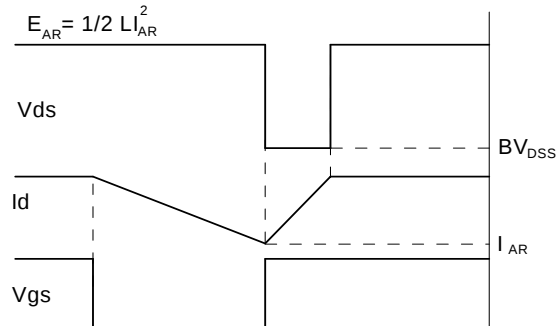
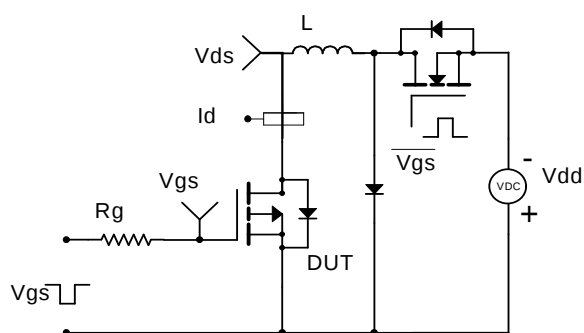
## Gate Charge Test Circuit &amp; Waveform



## Resistive Switching Test Circuit &amp; Waveforms



## Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



## Diode Recovery Test Circuit &amp; Waveforms

